

| | | | | |
|-----------------------------------|--|--|--|-------------|
| Notice of References Cited | | Application/Continuation No: 09/465,600 | Applicant(s)/Patent Under Reexamination EYDELBERG, ALEX I. | |
| | | Examiner LEYNNA T. HA | Art Unit 2135 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,161,177 | 12-2000 | Anderson, Eric D. | 713/2 |
| | B | US-5,892,906 | 04-1999 | Chou et al. | 713/202 |
| | C | US-6,202,091 | 03-2001 | Godse, Dhananjay | 709/222 |
| | D | US-6,718,464 | 04-2004 | Cromer et al. | 713/2 |
| | E | US-6,272,629 | 08-2001 | Stewart, David C. | 713/2 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.